BLF3G21-30

UHF power LDMOS transistor Rev. 01 — 14 February 2007

Product data sheet

Product profile 1.

1.1 General description

30 W LDMOS power transistor for base station applications at frequencies from HF to 2200 MHz.

Typical class-AB RF performance Table 1.

 I_{Dq} = 450 mA; T_h = 25 °C in a common source test circuit.

Mode of operation	f	P_L	Gp	η _D	IMD3	P _{L(1dB)}
	(MHz)	(W)	(dB)	(%)	(dB)	(W)
CW	2000	36	12.5	43	-	36
Two-tone	2000	30	13.5	35	-26	-
		0.1 to 10	13.8	-	< -50	-

Table 2. Typical class-A RF performance

 I_{Dq} = 1 A; T_h = 25 °C in a modified PHS test fixture.

Mode of operation	f	P _{L(AV)}	G _p	η _D	ACPR ₆₀₀
	(MHz)	(W)	(dB)	(%)	(dBc)
PHS	1880 to 1920	9	16	20	-75

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features

- Excellent back-off linearity
- Typical PHS performance at a supply voltage of 26 V and I_{Dq} of 1 A:
 - ◆ Average output power = 9 W
 - ◆ Gain = 16 dB (typ)
 - ◆ Efficiency = 20 %
 - ◆ ACPR₆₀₀ = -75 dBc
- Easy power control
- Excellent ruggedness
- High power gain
- Excellent thermal stability
- Designed for broadband operation (HF to 2200 MHz)



- No internal matching for broadband operation
- ESD protection

1.3 Applications

- RF power amplifiers for GSM, PHS, EDGE, CDMA and W-CDMA base stations and multicarrier applications in the HF to 2200 MHz frequency range
- Broadcast drivers

2. Pinning information

Table 3. Pinning

10010 01		
Pin	Description	Simplified outline Symbol
1	drain	
2	gate	
3	source	2 3 sym112

^[1] Connected to flange

3. Ordering information

Table 4. Ordering information

Type number	Package					
	Name	Description	Version			
BLF3G21-30	-	flanged LDMOST ceramic package; 2 mounting holes; 2 leads	SOT467C			

4. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage		-	65	V
V_{GS}	gate-source voltage		-	±15	V
I_{D}	drain current		-	4.5	Α
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature		-	200	°C

5. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Тур	Unit
$R_{th(j-c)}$	thermal resistance from junction to case	$T_h = 25 ^{\circ}C; P_{L(AV)} = 15 W$	[1]	1.6	K/W
$R_{th(j-h)}$	thermal resistance from junction to heatsink	$T_h = 25 ^{\circ}C; P_{L(AV)} = 15 W$	[2]	2.1	K/W

^[1] Thermal resistance is determined under specified RF operating conditions

6. Characteristics

Table 7. Characteristics

 $T_i = 25 \,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 0.7 \text{ mA}$	65	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; I_D = 70 \text{ mA}$	2.0	-	3.0	V
I _{DSS}	drain leakage current	$V_{GS} = 0 \text{ V}; V_{DS} = 28 \text{ V}$	-	-	5	μΑ
I _{DSX}	drain cut-off current	$V_{GS} = V_{GS(th)} + 9 V;$ $V_{DS} = 10 V$	9	-	-	Α
I _{GSS}	gate leakage current	$V_{GS} = \pm 15 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	11	nΑ
g _{fs}	transfer conductance	$V_{DS} = 10 \text{ V}; I_D = 2.5 \text{ A}$	-	3	-	S
R _{DS(on)}	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 9 \text{ V}; I_D = 2.5 \text{ A}$	-	0.3	-	Ω
C _{rs}	feedback capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 28 \text{ V};$ f = 1 MHz	-	1.7	-	pF

7. Application information

Table 8. Application information

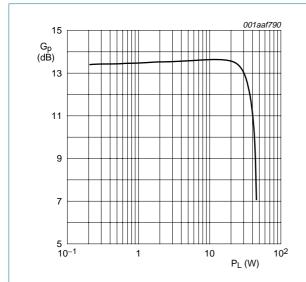
 V_{DS} = 26 V; T_h = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Mode of op	eration: Two-tone CW (100 k	Hz tone spacing); f = 20	000 MH	z; I _{Dq} = 4	50 mA	
Gp	power gain	$P_{L(PEP)} = 30 \text{ W}$	12.5	13.5	-	dB
RL _{in}	input return loss	$P_{L(PEP)} = 30 \text{ W}$	-	-16	-11	dB
η_{D}	drain efficiency	$P_{L(PEP)} = 30 \text{ W}$	32	35.0	-	%
IMD3	third order intermodulation	$P_{L(PEP)} = 30 \text{ W}$	-	-26	-23	dBc
di	distortion	P _{L(PEP)} < 10 W	-	< -50	-	dBc
Mode of op	eration: one-tone CW; f = 20	00 MHz; I _{Dq} = 450 mA				
Gp	power gain	$P_L = P_{L(1dB)} = 36 \text{ W}$	-	12.5	-	dB
η_{D}	drain efficiency	$P_L = P_{L(1dB)} = 36 \text{ W}$	-	43	-	%
Mode of op	Mode of operation: PHS; f = 1900 MHz; I _{Dq} = 1 A					
Gp	power gain	$P_{L(AV)} = 9 W$	-	16	-	dB
η_{D}	drain efficiency	$P_{L(AV)} = 9 W$	-	20	-	%

^[2] Depending on mounting condition in application

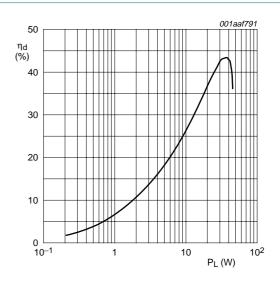
7.1 Ruggedness in class-AB operation

The BLF3G21-30 is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: V_{DS} = 26 V; f = 2200 MHz at rated load power.



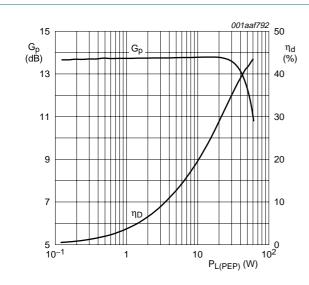
 $V_{DS} = 26 \text{ V}; I_{Da} = 450 \text{ mA}; T_h = 25 \,^{\circ}\text{C}; f = 2000 \text{ MHz}$

Fig 1. Power gain as function of CW load power; typical values



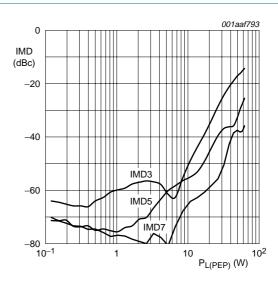
 V_{DS} = 26 V; I_{Dq} = 450 mA; T_h = 25 °C; f = 2000 MHz

Fig 2. Drain efficiency as function of CW load power; typical values



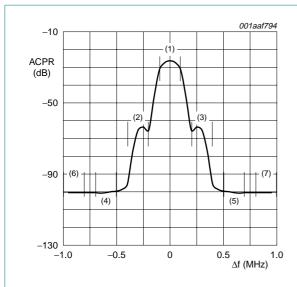
 V_{DS} = 26 V; I_{Dq} = 450 mA; $T_h \le$ 25 °C; f_1 = 2000 MHz; f_2 = 2000.1 MHz

Fig 3. Two-tone power gain and drain efficiency as functions of peak envelope load power; typical values



 V_{DS} = 26 V; I_{Dq} = 450 mA; $T_h \le$ 25 °C; f_1 = 2000 MHz; f_2 = 2000.1 MHz

Fig 4. Two-tone intermodulation distortion as function of peak envelope load power; typical values



- (1) 192 kHz channel bandwidth
- (2) -ACPR₃₀₀ at 192 kHz bandwidth
- (3) +ACPR₃₀₀ at 192 kHz bandwidth
- (4) -ACPR₆₀₀ at 192 kHz bandwidth
- (5) +ACPR₆₀₀ at 192 kHz bandwidth
- (6) -ACPR₉₀₀ at 192 kHz bandwidth
- (7) +ACPR $_{900}$ at 192 kHz bandwidth $V_{DS}=26 \text{ V; } I_{Dq}=1000 \text{ mA; } T_h \leq 25 \text{ °C;} \\ f_c=1900 \text{ MHz; } P_{L(AV)}=9 \text{ W}$

Fig 5. ACPR performance under PHS conditions, measured in application board

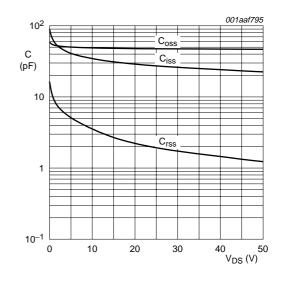
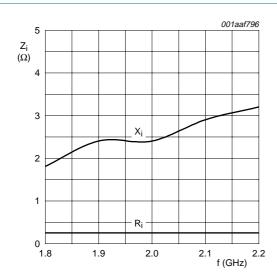
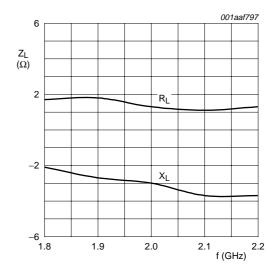


Fig 6. C_{iss}, C_{rss} and C_{oss} as functions of drain supply voltage; typical values



 V_{DS} = 26 V; I_{Dq} = 450 mA; P_L = 45 W; $T_h \leq$ 25 °C

Fig 7. Input impedance as function of frequency (series components); typical values



 V_{DS} = 26 V; I_{Dq} = 450 mA; P_L = 45 W; $T_h \leq$ 25 °C

Fig 8. Load impedance as function of frequency (series components); typical values

00 Test information

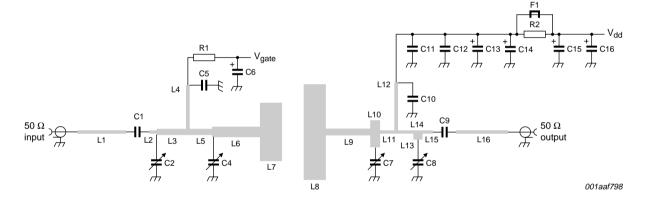


Fig 9. Class-AB test circuit for 2 GHz

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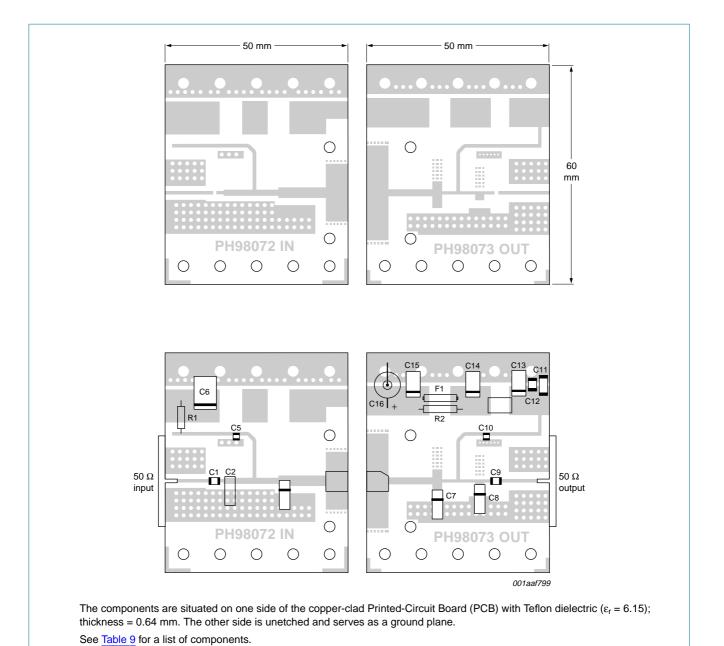


Fig 10. Component layout for 2 GHz class-AB test circuit

Table 9. List of components (see Figure 9 and Figure 10)

Component	Description		Value	Dimensions	Catalogue No.
C1, C9	multilayer ceramic chip capacitor	[2]	11 pF		
C2, C4, C7, C8	Tekelec variable capacitor; type 37271		0.6 pF to 4.5 pF		
C5, C10	multilayer ceramic chip capacitor	[1]	12 pF		
C6, C13, C14, C15	tantalum SMD capacitor		4.5 μF; 50 V		
C11	multilayer ceramic chip capacitor	[2]	1 nF		
C12	multilayer ceramic chip capacitor		100 nF		2222 581 16641
C16	electrolytic capacitor		100 μF; 63 V		2222 037 58101
F1	ferrite SMD bead			8DS3/3/8/9-4S2	4330 030 36301
L1	stripline	[3]	50 Ω	13 mm \times 0.9 mm	
L2	stripline	[3]	50 Ω	$2 \text{ mm} \times 0.9 \text{ mm}$	
L3	stripline	[3]	$34.3~\Omega$	15 mm \times 1.7 mm	
L4, L12	stripline	[3]	50 Ω	$37~\text{mm}\times0.9~\text{mm}$	
L5	stripline	[3]	$34.3~\Omega$	$6 \text{ mm} \times 1.7 \text{ mm}$	
L6	stripline	[3]	23.6Ω	13 mm \times 2.9 mm	
L7	stripline	[3]	5.6 Ω	$6~\text{mm} \times 15.8~\text{mm}$	
L8	stripline	[3]	3.5 Ω	$6~\text{mm} \times 26~\text{mm}$	
L9	stripline	[3]	31.9 Ω	12 mm × 1.9 mm	
L10	stripline	[3]	24.9 Ω	$7.4~\text{mm} \times 2.7~\text{mm}$	
L11	stripline	[3]	50 Ω	$3 \text{ mm} \times 0.9 \text{ mm}$	
L13	stripline	[3]	50 Ω	4.15 mm × 0.9 mm	
L14	stripline	[3]	26.3 Ω	$2.5~\text{mm} \times 2.5~\text{mm}$	
L15	stripline	[3]	50 Ω	$2.8~\text{mm} \times 0.9~\text{mm}$	
L16	stripline	[3]	50 Ω	14 mm × 0.9 mm	
R1, R2	metal film resistor		10 Ω; 0.6 W		2322 156 11009

^[1] American Technical Ceramics type 100B or capacitor of same quality

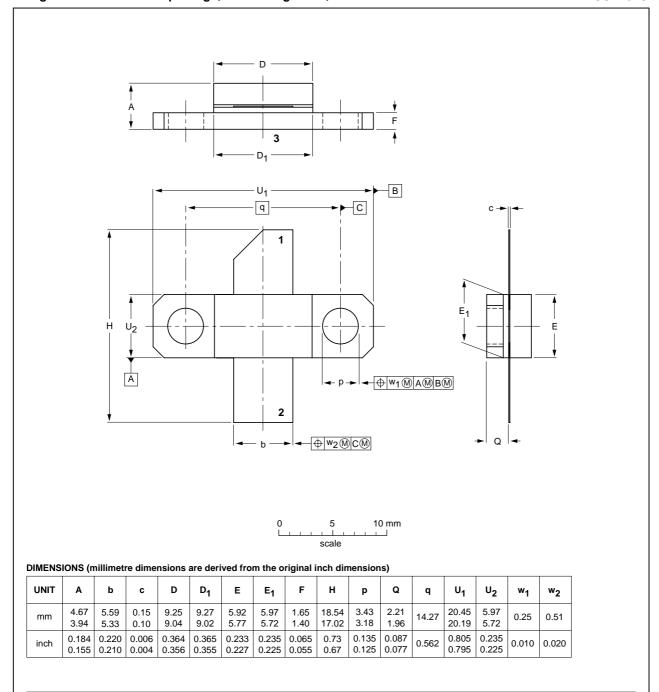
^[2] American Technical Ceramics type 100A or capacitor of same quality

^[3] The striplines are on a double copper-clad Printed-Circuit Board (PCB) with Teflon dielectric (ϵ_r = 6.15); thickness = 0.64 mm

9. Package outline

Flanged LDMOST ceramic package; 2 mounting holes; 2 leads

SOT467C



REFERENCES

EIAJ

JEDEC

Fig 11. Package outline SOT467C

OUTLINE

VERSION

SOT467C

IEC

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ISSUE DATE

99-12-06

99-12-28

EUROPEAN

PROJECTION

10. Abbreviations

Table 10. Abbreviations

Acronym	Description	
CDMA	Code Division Multiple Access	
EDGE	Enhanced Data rates for the GSM Evolution	
GSM	Global System for Mobile communications	
HF	High Frequency	
LDMOS	Laterally Diffused Metal Oxide Semiconductor	
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor	
PHS	Personal HandyPhone System	
RF	Radio Frequency	
SMD	Surface-Mount Device	
UHF	Ultra High Frequency	
VSWR	Voltage Standing-Wave Ratio	
W-CDMA	Wideband Code Division Multiple Access	

11. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF3G21-30_1	20070214	Product data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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UHF power LDMOS transistor

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